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- **EPIC**[™] (Enhanced-Performance Implanted **CMOS) Submicron Process**
- Typical VOLP (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC} = 3.3 V, $T_A = 25^{\circ}C$
- Power Off Disables Outputs, Permitting Live Insertion
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V_{CC})
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and DIPs (J)

description

The SN54LVC541A octal buffer/driver is designed for 2.7-V to 3.6-V V_{CC} operation and the SN74LVC541A octal buffer/driver is designed for 1.65-V to 3.6-V V_{CC} operation.

The 'LVC541A devices are ideal for driving bus lines or buffering memory address registers.

These devices feature inputs and outputs on opposite sides of the package to facilitate printed circuit board layout.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output enable (OE1 or OE2) input is high, all eight outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, $\overline{\mathsf{OE}}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

The SN54LVC541A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LVC541A is characterized for operation from -40°C to 85°C.



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On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production
processing does not necessarily include testing of all parameters.

SN54LVC541A J OR W PACKAGE
SN74LVC541A DB, DW, OR PW PACKAGE
(TOP VIEW)

OE1 A1 A2 A3 A4 A5 A6 A7	[] 3 [] 4 [] 5 [] 6 [] 7 [] 8	20 19 18 17 16 15 14 13	V _{CC} OE2 Y1 Y2 Y3 Y4 Y5 Y6								
A8 GND		12 11] Y7] Y8								
0.12	٩_``		۲.°								

SN54LVC541A ... FK PACKAGE (TOP VIEW)

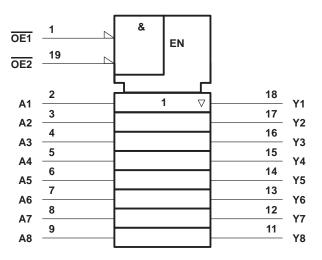
	()	
	A2 A1 OE1 OE2 OE2	
		-
A3	3 2 1 20 19 4 18	Y1
A3 A4 A5 A6 A7	5 17	Y2 Y3
A5	6 16 7 15	Y3
A6	7 15	Y4 Y5
A7	8 14	Y5
	9 10 11 12 13	
	COCC S S S S S S S S S S S S S S S S S S	
	$\triangleleft Z \succ \succ \succ$	
	0	

SN54LVC541A, SN74LVC541A OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS SCAS298H – JANUARY 1993 – REVISED JUNE 1998

FUNCTION TABLE

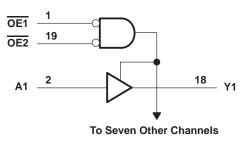
	INPUTS	OUTPUT								
OE1	OE2	Α	Y							
L	L	L	L							
L	L	Н	н							
Н	Х	Х	Z							
Х	н	Х	Z							

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high-impedance or power-off state, V_O	
(see Note 1)	–0.5 V to 6.5 V
Voltage range applied to any output in the high or low state, V _O	
(see Notes 1 and 2)	\dots –0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} (V _I < 0)	
Output clamp current, I _{OK} (V _O < 0)	
Continuous output current, I _O	±50 mA
Continuous current through V_{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3): DB package	115°C/W
DW package	
PW package	128°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The value of V_{CC} is provided in the recommended operating conditions table.

3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

			SN54L	VC541A	SN74L	SN74LVC541A		
			MIN	MAX	MIN	MAX	UNIT	
\/	Current under an	Operating	2	3.6	1.65	3.6	V	
VCC	Supply voltage	Data retention only	1.5		1.5		v	
		V _{CC} = 1.65 V to 1.95 V			$0.65 \times V_{CC}$			
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V			1.7		V	
		V _{CC} = 2.7 V to 3.6 V	2		2			
		V _{CC} = 1.65 V to 1.95 V				$0.35 \times V_{CC}$		
VIL	Low-level input voltage	V _{CC} = 2.3 V to 2.7 V				0.7	V	
		V _{CC} = 2.7 V to 3.6 V		0.8		0.8		
VI	Input voltage		0	5.5	0	5.5	V	
	Output voltage	High or low state	0	VCC	0	VCC		
VO		3 state	0	5.5	0	5.5	V	
		V _{CC} = 1.65 V				-4		
1	Lich lovel output outpot	V _{CC} = 2.3 V				-8		
ЮН	High-level output current	V _{CC} = 2.7 V		-12		-12	mA	
		$V_{CC} = 3 V$		-24		-24		
		V _{CC} = 1.65 V				4		
1		V _{CC} = 2.3 V				8	mA	
IOL	Low-level output current	V _{CC} = 2.7 V		12		12		
		V _{CC} = 3 V		24		24		
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS			SN54	SN54LVC541A			SN74LVC541A		
PARAMETER	TEST CONDI	IIONS	Vcc	MIN	TYP†	MAX	MIN	TYP†	MAX	UNI
	L		1.65 V to 3.6 V				V _{CC} -0.2			
	IOH = -100 μA		2.7 V to 3.6 V	V _{CC} -0.2						
VOH	I _{OH} = -4 mA		1.65 V				1.2			
	I _{OH} = -8 mA		2.3 V				1.7			V
	10 m A		2.7 V	2.2			2.2			
	I _{OH} = -12 mA		3 V	2.4			2.4			
	I _{OH} = -24 mA		3 V	2.2			2.2			
	I _{OL} = 100 μA		1.65 V to 3.6 V						0.2	V
			2.7 V to 3.6 V			0.2				
Ve	$I_{OL} = 4 \text{ mA}$		1.65 V						0.45	
VOL	I _{OL} = 8 mA I _{OL} = 12 mA I _{OL} = 24 mA		2.3 V						0.7	
			2.7 V			0.4			0.4	
			3 V			0.55			0.55	
lj	$V_{I} = 0$ to 5.5 V		3.6 V			±5			±5	μA
l _{off}	$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		0						±10	μA
I _{OZ}	V _O = 0 to 5.5 V		3.6 V			±15			±10	μA
	$V_{I} = V_{CC}$ or GND		0.01/			10			10	
ICC	$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{\ddagger}$	1 ^O = 0	3.6 V			10			10	μA
ΔICC	One input at $V_{CC} - 0.6 V$, Other inputs at V_{CC} or GND		2.7 V to 3.6 V			500			500	μA
Ci	$V_{I} = V_{CC} \text{ or } GND$		3.3 V		4			4		pF
Co	$V_{O} = V_{CC} \text{ or } GND$		3.3 V		5.5			5.5		pF

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25° C.

[‡] This applies in the disabled state only.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)			V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V	
			MIN	MAX	MIN	MAX	
^t pd	А	Y		5.6	1	5.1	ns
ten	OE	Y		7.5	1	7	ns
^t dis	OE	Y		7.7	1	7	ns



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switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

						SN74L\	/C541A					
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 1.8 V V _{CC} = 2.5 V V _{CC} = 2.5 V ± 0.15 V ± 0.2 V V _{CC} =		V _{CC} = 1.8 V ± 0.15 V		V _{CC} = 1.8 V ± 0.15 V		2.7 V	= ۷ _{CC} ± 0.3	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
^t pd	A	Y	†	†	†	†		5.6	1.5	5.1	ns	
t _{en}	OE	Y	†	†	†	†		7.5	1.5	7	ns	
^t dis	ŌĒ	Y	†	†	†	†		7.7	1.5	7	ns	
^t sk(o) [‡]										1	ns	

 $\overset{\dagger}{}$ This information was not available at the time of publication.

[‡] Skew between any two outputs of the same package switching in the same direction

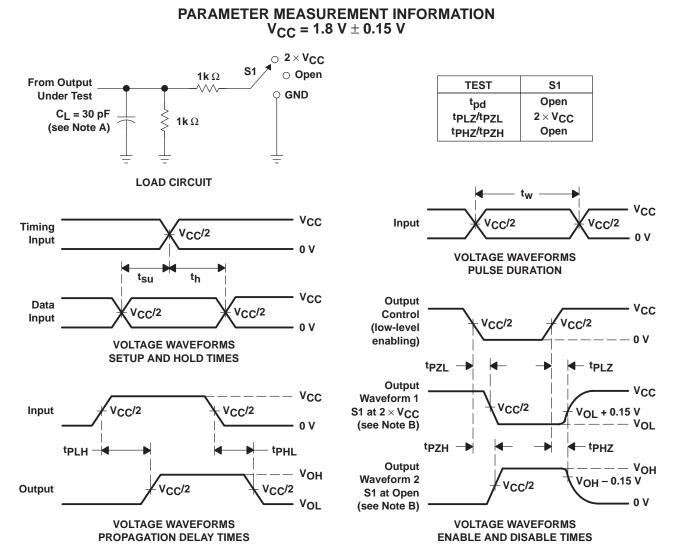
operating characteristics, $T_A = 25^{\circ}C$

PARAMETER			TEST CONDITIONS	V _{CC} = 1.8 V ± 0.15 V	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT
			CONDITIONS	TYP	TYP	TYP	
Card	Power dissipation capacitance	Outputs enabled	f = 10 MHz	†	†	33	pF
⊂pd	Cpd per buffer/driver	Outputs disabled		†	†	2	μr

[†]This information was not available at the time of publication.



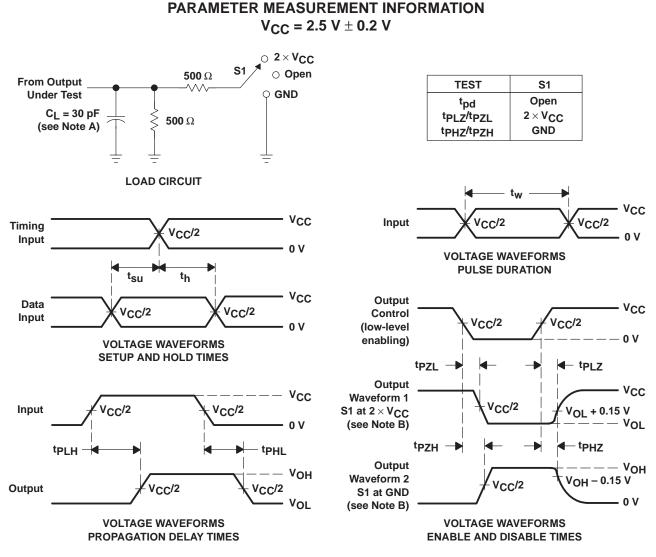
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- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR≤10 MHz, Z_O = 50 Ω, t_f≤2 ns. t_f≤2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. tpzL and tpzH are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .





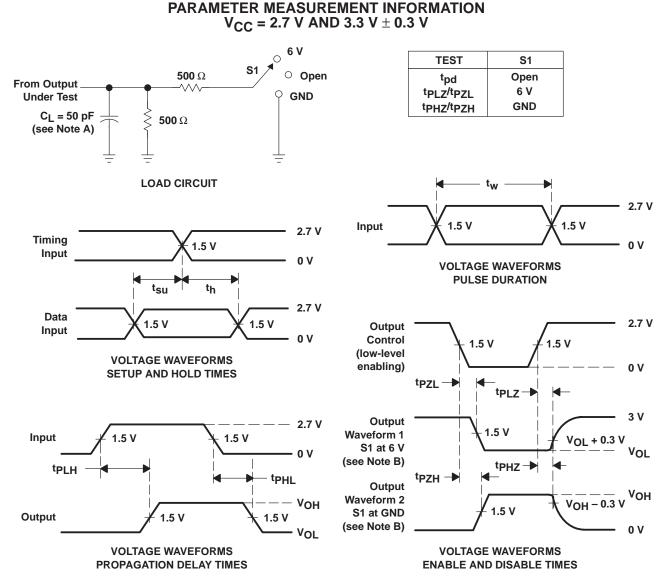


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 C. All input pulses are supplied by generators having the following characteristics: PRR≤10 MHz, Z_O = 50 Ω, t_f≤2 ns. t_f≤2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tpLz and tpHz are the same as tdis.
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. tp μ and tp μ are the same as t_{pd}.

Figure 2. Load Circuit and Voltage Waveforms



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 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. tpzL and tpzH are the same as ten.
 - G. tpLH and tpHL are the same as tpd.

Figure 3. Load Circuit and Voltage Waveforms



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